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TEXAS INSTRUMENTS

TCAN1051H, TCAN1051HV
TCAN1051HG, TCAN1051HGV
SLLSES8B –MARCH 2016–REVISED MAY 2016

TCAN1051 Fault Protected CAN Transceiver with CAN FD

1 Features

- Meets the December 17th, 2015 Draft of ISO 11898-2 Physical Layer Update
- Meets the Released ISO 11898-2:2007 and ISO 11898-2:2003 Physical Layer Standards
- 'Turbo' CAN:
  - All devices support 2 Mbps CAN FD (Flexible Data Rate) and "G" options support 5 Mbps
  - Short and Symmetrical Propagation Delay Times and Fast Loop Times for Enhanced Timing Margin
  - Higher Data Rates in Loaded CAN Networks
- I/O Voltage Range Supports 3.3 V and 5 V MCUs
- Ideal Passive Behavior When Unpowered
  - Bus and Logic Terminals are High Impedance (no load)
  - Power Up/Down With Glitch Free Operation On Bus and RXD Output
- Protection Features
  - HBM ESD Protection: ±16 kV
  - IEC ESD Protection up to ±15 kV
  - Bus Fault Protection: ±70 V
  - Undervoltage Protection on V_{CC} and V_{IO} (V variants only) Supply Terminals
  - Driver Dominant Time Out (TXD DTO) - Data rates down to 10 kbps
  - Thermal Shutdown Protection (TSD)
- Receiver Common Mode Input Voltage: ±30 V
- Typical Loop Delay: 110 ns
- Junction Temperatures from –55°C to 150°C

2 Applications

- All devices support highly loaded CAN networks
- Heavy Machinery ISO11783 Applications
- Industrial Automation, Control, Sensors and Drive Systems
- Building, Security and Climate Control Automation
- Telecom Base Station Status and Control
- CAN Bus Standards Such as CANopen, DeviceNet, NMEA2000, ARNIC825, ISO11783, CANaerospace

3 Description

This CAN transceiver family meets the ISO11898-2 (2016) High Speed CAN (Controller Area Network) physical layer standard. All devices are designed for use in CAN FD networks up to 2 Mbps (megabits per second). Devices with part numbers that include the "G" suffix are designed for data rates up to 5 Mbps, and versions with the "V" have a secondary power supply input for I/O level shifting the input pin thresholds and RXD output level. This family of devices comes with silent mode which is also commonly referred to as listen-only mode. Additionally, all devices include many protection features to enhance device and network robustness.

Device Information

ORDER NUMBER	PACKAGE	BODY SIZE
TCAN1051Hx	SOIC (8)	4.90 mm × 3.91 mm
	VSON (8)	3.00 mm x 3.00 mm

Functional Block Diagram
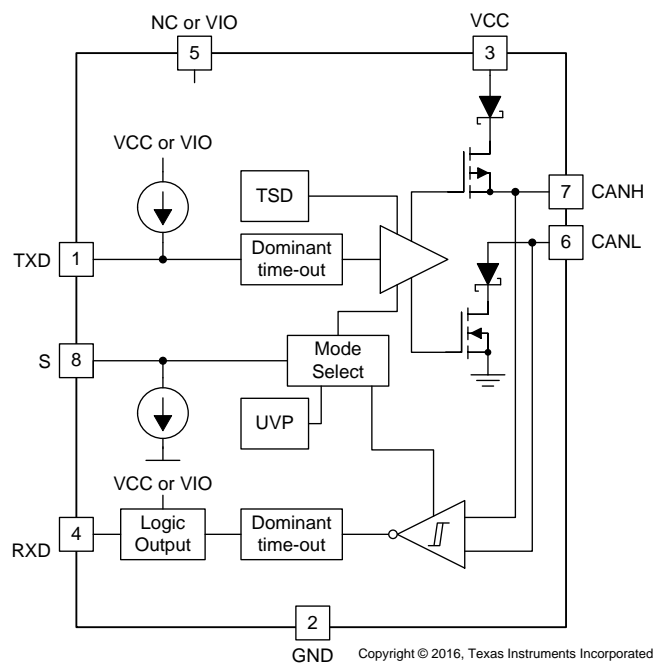
A. Terminal 5 function is device dependent; NC on devices without the "V" suffix, and V_{IO} for I/O level shifting for devices with the "V" suffix.

B. RXD logic output is driven to V_{CC} on devices without the "V" suffix, and V_{IO} for devices with the "V" suffix.

Table of Contents

4 Revision History

Changes from Revision A (April 2016) to Revision B   **Page**

- Added the VSON (8) pin package to the *Device Information* table 1
- Added the VSON (8) pin package to the *Pin Configurations and Functions* 3
- Added the DRB package to the *Thermal Information* table 5

**Changes from Original (March 2016) to Revision A**   **Page**

- Changed the device status From: Product Preview To: Production 1
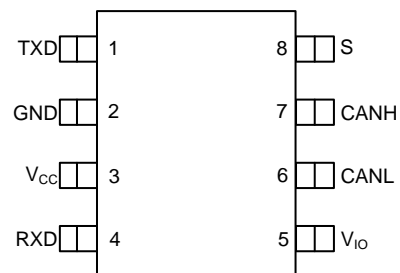
5 Device Comparison Table

DEVICE NUMBER	BUS FAULT PROTECTION	5-Mbps FLEXIBLE DATA RATE	3-V LEVEL SHIFTER INTEGRATED	PIN 8 MODE SELECTION
TCAN1051H	±70 V			
TCAN1051HG	±70 V	X		
TCAN1051HGV	±70 V	X	X	Silent Mode
TCAN1051HV	±70 V		X	

6 Pin Configurations and Functions

D Package for Base, (H), (G), and (HG) Devices
8 PIN (SOIC)
Top View

```
TXD   1        8   S
GND   2        7   CANH
VCC   3        6   CANL
RXD   4        5   NC
```
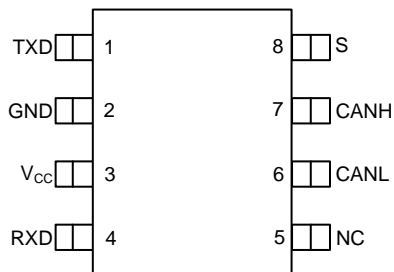
D Package for (V), (GV), (HV) and (HGV) Devices
8 PIN (SOIC)
Top View

```
TXD   1        8   S
GND   2        7   CANH
VCC   3        6   CANL
RXD   4        5   VIO
```

D Package for (HV) and (HGV)
8 PIN (VSON)
Top View

```
TXD   1        8   STB
GND   2        7   CANH
VCC   3        6   CANL
RXD   4        5   NC
```

D Package for (HV) and (HGV)
8 PIN (VSON)
Top View

```
TXD   1        8   S
GND   2        7   CANH
VCC   3        6   CANL
RXD   4        5   VIO
```
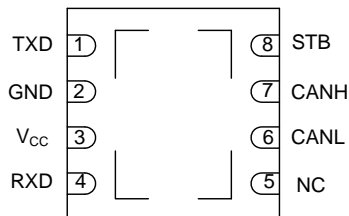
Pin Functions

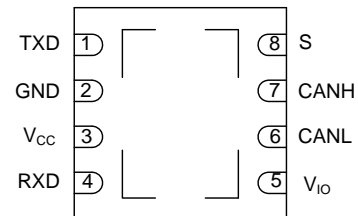| PINS			TYPE	DESCRIPTION
NAME	(H), (HG)	(HV), (HGV)		
TXD	1	1	DIGITAL INPUT	CAN transmit data input (LOW for dominant and HIGH for recessive bus states)
GND	2	2	GND	Ground connection
VCC	3	3	POWER	Transceiver 5-V supply voltage
RXD	4	4	DIGITAL OUTPUT	CAN receive data output (LOW for dominant and HIGH for recessive bus states)
NC	5	—	—	No Connect
V_{IO}	—	5	POWER	Transceiver I/O level shifting supply voltage (Devices with "V" suffix only)
CANL	6	6	BUS I/O	Low level CAN bus input/output line
CANH	7	7	BUS I/O	High level CAN bus Input/output line
S	8	8	DIGITAL INPUT	Silent Mode control input (active high)

Product Folder Links: *TCAN1051H TCAN1051HV TCAN1051HG TCAN1051HGV*

7 Specifications

7.1 Absolute Maximum Ratings[(1) (2)]

			MIN	MAX	UNIT
V_{CC}	5-V Bus Supply Voltage Range	All Devices	−0.3	7	V
V_{IO}	I/O Level-Shifting Voltage Range	Devices with the "V" Suffix	−0.3	7	V
V_{BUS}	CAN Bus I/O voltage range (CANH, CANL)	Devices with the "H" Suffix	-70	70	V
$V_{(Logic\_Input)}$	Logic input terminal voltage range (TXD, S)		−0.3	+7 and $V_I \leq V_{IO} + 0.3$	V
$V_{(Logic\_Output)}$	Logic output terminal voltage range (RXD)	All Devices	−0.3	+7 and $V_I \leq V_{IO} + 0.3$	V
$I_{O(RXD)}$	RXD (Receiver) output current		−8	8	mA
T_J	Operating virtual junction temperature range (see Thermal Information)		−55	150	°C

(1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated condition for extended periods may affect device reliability.
(2) All voltage values, except differential I/O bus voltages, are with respect to ground terminal.

7.2 ESD Ratings

	TEST CONDITIONS			VALUE	UNIT
Human Body Model (HBM) ESD stress voltage	All terminals[(1)]			±6000	V
	CAN bus terminals (CANH, CANL) to GND[(2)]			±10000	
Charged Device Model (CDM) ESD stress voltage	All terminals[(3)]			±750	V
Machine Model	All terminals[(4)]			±200	V
System Level Electro-Static Discharge (ESD)	CAN bus terminals (CANH, CANL) to GND	IEC 61000-4-2: Unpowered Contact Discharge		±15000	V
		IEC 61000-4-2: Powered Contact Discharge		±8000	
System Level Electrical fast transient (EFT)	CAN bus terminals (CANH, CANL) to GND	IEC 61000-4-2: Powered on Contact Discharge, Criteria A		±4000	V

(1) Tested in accordance to JEDEC Standard 22, Test Method A114.
(2) Test method based upon JEDEC Standard 22 Test Method A114, CAN bus is stressed with respect to GND.
(3) Tested in accordance to JEDEC Standard 22, Test Method C101.
(4) Tested in accordance to JEDEC Standard 22, Test Method A115.

Product Folder Links: *TCAN1051H TCAN1051HV TCAN1051HG TCAN1051HGV*

7.3 Recommended Operating Conditions

		MIN	MAX	UNIT
V_{CC}	5-V Bus Supply Voltage Range	4.5	5.5	V
V_{IO}	I/O Level-Shifting Voltage Range	2.8	5.5	
$I_{OH(RXD)}$	RXD terminal HIGH level output current	−2		mA
$I_{OL(RXD)}$	RXD terminal LOW level output current		2	

7.4 Thermal Information

THERMAL METRIC[1]		TEST CONDITIONS	TCAN1051		UNIT
			D (SOIC)	DRB (VSON)	
			8 Pins	8 Pins	
$R_{\theta JA}$	Junction-to-air thermal resistance	High-K thermal resistance[2]	105.8	40.2	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance[3]		46.8	49.7	°C/W
$R_{\theta JC(TOP)}$	Junction-to-case (top) thermal resistance[4]		48.3	15.7	°C/W
Ψ_{JT}	Junction-to-top characterization parameter[5]		8.7	0.6	°C/W
Ψ_{JB}	Junction-to-board characterization parameter[6]		46.2	15.9	°C/W
P_D	Average power dissipation	V_{CC} = 5 V, V_{IO} = 5 V (if applicable), T_J = 27°C, R_L = 60 Ω, S at 0 V, Input to TXD at 250 kHz, C_{L_RXD} = 15 pF. Typical CAN operating conditions at 500 kbps with 25% transmission (dominant) rate.	52	TBD	mW
		V_{CC} = 5.5 V, V_{IO} = 5.5 V (if applicable), T_J = 150°C, R_L = 50 Ω, S at 0 V, Input to TXD at 500 kHz, C_{L_RXD} = 15 pF. Typical high load CAN operating conditions at 1 Mbps with 50% transmission (dominant) rate and loaded network.	124	TBD	
T_{TSD}	Thermal shutdown temperature		170	TBD	°C
T_{TSD_HYS}	Thermal shutdown hysteresis		5	TBD	°C

(1) For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report, SPRA953.
(2) The junction-to-ambient thermal resistance under natural convection is obtained in a simulation on a JEDEC-standard, High-K board, as specified in JESD51-7, in an environment described in JESD51-2a.
(3) The junction-to-board thermal resistance is obtained by simulating in an environment with a ring cold plate fixture to control the PCB temperature, as described in JESD51-8.
(4) The junction-to-case (top) thermal resistance is obtained by simulating a cold plate test on the package top. No specific JEDEC-standard test exists, but a close description can be found in the ANSI SEMI standard G30-88.
(5) The junction-to-top characterization parameter, Ψ_{JT}, estimates the junction temperature of a device in a real system and is extracted from the simulation data for obtaining θ_{JA}, using a procedure described in JESD51-2a (sections 6 and 7).
(6) The junction-to-board characterization parameter, Ψ_{JB} estimates the junction temperature of a device in a real system and is extracted from the simulation data for obtaining θ_{JA}, using a procedure described in JESD51-2a (sections 6 and 7).

7.5 Electrical Characteristics

Over recommended operating conditions, T_A = –55°C to 125°C (unless otherwise noted).

PARAMETER			TEST CONDITIONS	MIN	TYP[1]	MAX	UNIT
SUPPLY CHARACTERISTICS							
I_{CC}	5-V Supply current	Normal mode (dominant)	See Figure 5, TXD = 0 V, R_L = 60 Ω, C_L = open, R_{CM} = open, S = 0V		40	70	mA
			See Figure 5, TXD = 0 V, R_L = 50 Ω, C_L = open, R_{CM} = open, S = 0V		45	80	
		Normal mode (dominant – bus fault)	See Figure 5, TXD = 0 V, S = 0V, CANH = -12V, R_L = open, C_L = open, R_{CM} = open			180	
		Normal mode (recessive)	See Figure 5, TXD = V_{CC}, R_L = 50 Ω, C_L = open, R_{CM} = open, S = 0V		1.5	2.5	
		Silent mode	See Figure 5, TXD = V_{CC}, R_L = 50 Ω, C_L = open, R_{CM} = open, S = V_{CC}		1.5	2.5	
I_{IO}	I/O supply current	Normal and Silent modes	RXD Floating, TXD = S = 0 or 5.5 V		90	300	µA
UV_{VCC}	Rising undervoltage detection on V_{CC} for protected mode				4.2	4.4	V
	Falling undervoltage detection on V_{CC} for protected mode		All devices	3.8	4.0	4.25	
$V_{HYS(UVVCC)}$	Hysteresis voltage on UV_{VCC}				200		mV
UV_{VIO}	Undervoltage detection on V_{IO} for protected mode		Devices with the "V" Suffix (I/O level-shifting)	1.3		2.75	V
$V_{HYS(UVVIO)}$	Hysteresis voltage on UV_{VIO} for protected mode				80		mV
S TERMINAL (MODE SELECT INPUT)							
V_{IH}	High-level input voltage		Devices with the "V" suffix (I/O level-shifting)	0.7 x V_{IO}			V
			Devices without the "V" suffix (5-V only)	2			
V_{IL}	Low-level input voltage		Devices with the "V" suffix (I/O level-shifting)			0.3 x V_{IO}	
			Devices without the "V" suffix (5-V only)			0.8	
I_{IH}	High-level input leakage current		S = V_{CC} or V_{IO} = 5.5 V			30	
I_{IL}	Low-level input leakage current		S = 0 V, V_{CC} = V_{IO} = 5.5 V	–2	0	2	µA
$I_{lkg(OFF)}$	Unpowered leakage current		S = 5.5 V, V_{CC} = V_{IO} = 0 V	-1		1	
TXD TERMINAL (CAN TRANSMIT DATA INPUT)							
V_{IH}	High-level input voltage		Devices with the "V" suffix (I/O level-shifting)	0.7 x V_{IO}			V
			Devices without the "V" suffix (5-V only)	2			
V_{IL}	Low-level input voltage		Devices with the "V" suffix (I/O level-shifting)			0.3 x V_{IO}	
			Devices without the "V" suffix (5-V only)			0.8	
I_{IH}	High-level input leakage current		TXD = V_{CC} = V_{IO} = 5.5 V	–2.5	0	1	
I_{IL}	Low-level input leakage current		TXD = 0 V, V_{CC} = V_{IO} = 5.5 V	–100	-25	–7	µA
$I_{lkg(OFF)}$	Unpowered leakage current		TXD = 5.5 V, V_{CC} = V_{IO} = 0 V	–1	0	1	
C_I	Input capacitance		V_{IN} = 0.4 * sin(4E6 * π * t) + 2.5 V		5		pF

(1) All typical values are at 25°C and supply voltages of V_{CC} = 5 V and V_{IO} = 5 V, R_L = 60 Ω.

Electrical Characteristics (continued)

Over recommended operating conditions, T_A = –55°C to 125°C (unless otherwise noted).

PARAMETER			TEST CONDITIONS	MIN	TYP[1]	MAX	UNIT
RXD TERMINAL (CAN RECEIVE DATA OUTPUT)							
V_{OH}	High-level output voltage		Devices with the "V" suffix (I/O level-shifting), See Figure 6, I_O = –2 mA	$0.8 \times V_{IO}$			V
			Devices without the "V" suffix (5-V only), See Figure 6, I_O = –2 mA	4	4.6		
V_{OL}	Low-level output voltage		Devices with the "V" suffix (I/O level-shifting), See Figure 6, I_O = +2 mA			$0.2 \times V_{IO}$	
			Devices without the "V" suffix (5-V only), See Figure 6, I_O = +2 mA		0.2	0.4	
$I_{lkg(OFF)}$	Unpowered leakage current		RXD = 5.5 V, V_{CC} = 0 V, V_{IO} = 0 V	–1	0	1	µA
DRIVER ELECTRICAL CHARACTERISTICS							
$V_{O(DOM)}$	Bus output voltage (dominant	CANH	See Figure 13 and Figure 5, TXD = 0 V, S = 0 V, 50 Ω ≤ R_L ≤ 65 Ω, C_L = open, R_{CM} = open	2.75		4.5	V
		CANL		0.5		2.25	
$V_{O(REC)}$	Bus output voltage (recessive)	CANH and CANL	See Figure 13 and Figure 5, TXD = V_{CC}, V_{IO} = V_{CC}, S = V_{CC} or 0 V [2], R_L = open (no load), R_{CM} = open	2	$0.5 \times V_{CC}$	3	
$V_{OD(DOM)}$	Differential output voltage (dominant)	CANH - CANL	See Figure 13 and Figure 5, TXD = 0 V, S = 0 V, 45 Ω ≤ R_L < 50 Ω, C_L = open, R_{CM} = open	1.4		3	V
			See Figure 13 and Figure 5, TXD = 0 V, S = 0 V, 50 Ω ≤ R_L ≤ 65 Ω, C_L = open, R_{CM} = open	1.5		3	
			See Figure 13 and Figure 5, TXD = 0 V, S = 0 V, R_L = 2240 Ω, C_L = open, R_{CM} = open	1.5		5	
$V_{OD(REC)}$	Differential output voltage (recessive)	CANH - CANL	See Figure 13 and Figure 5, TXD = V_{CC}, S = 0 V, R_L = 60 Ω, C_L = open, R_{CM} = open	–120		12	mV
			See Figure 13 and Figure 5, TXD = V_{CC}, S = 0 V, R_L = open (no load), C_L = open, R_{CM} = open	–50		50	
V_{SYM}	Output symmetry (dominant or recessive) ($V_{CC} - V_{O(CANH)} - V_{O(CANL)}$)		See Figure 13 and Figure 5, S at 0 V, R_L = 60 Ω, C_L = open, R_{CM} = open	–0.4		0.4	V
$I_{OS(SS\_DOM)}$	Short-circuit steady-state output current, dominant		See Figure 13 and Figure 11, V_{CANH} = -5 V, CANL = open, TXD = 0 V	–100			mA
			See Figure 13 and Figure 11, V_{CANL} = 40 V, CANH = open, TXD = 0 V			100	
$I_{OS(SS\_REC)}$	Short-circuit steady-state output current, recessive		See Figure 13 and Figure 11, –27 V ≤ V_{BUS} ≤ 32 V, Where V_{BUS} = CANH = CANL, TXD = V_{CC}, all modes	–5		5	mA

(2) For the bus output voltage (recessive) will be the same if the device is in Normal mode with S terminal LOW or if the device is in Silent mode with the S terminal is HIGH.

Electrical Characteristics (continued)

Over recommended operating conditions, T_A = –55°C to 125°C (unless otherwise noted).

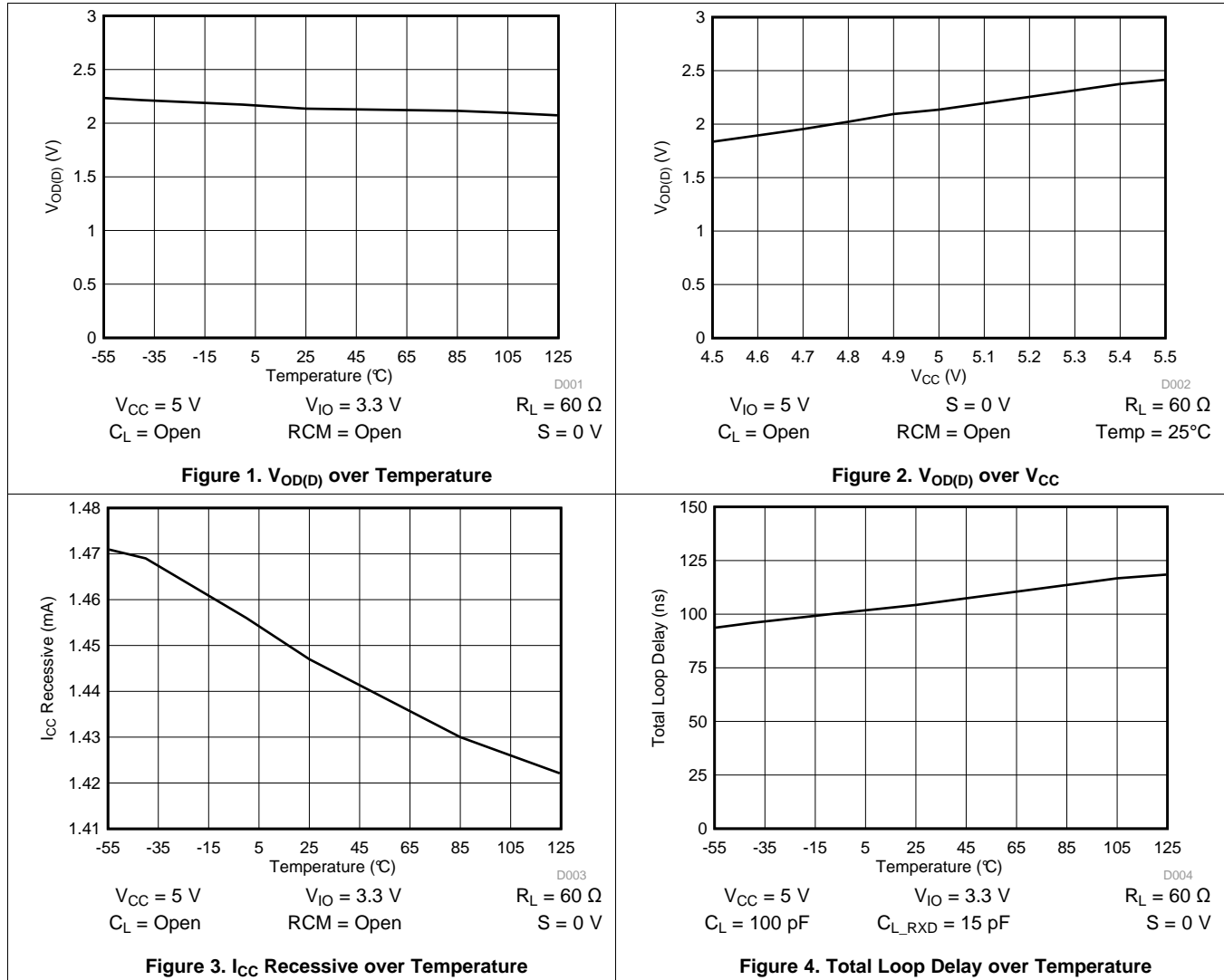| PARAMETER		TEST CONDITIONS	MIN	TYP[1]	MAX	UNIT
RECEIVER ELECTRICAL CHARACTERISTICS						
V_{CM}	Common mode range, normal mode	See Figure 6, Table 6 and Table 1, S = 0 or V_{CC} or V_{IO}	-30		+30	V
V_{IT+}	Positive-going input threshold voltage, all modes	See Figure 6, Table 6 and Table 1, S = 0 or V_{CC} or V_{IO}, -20 V ≤ V_{CM} ≤ +20 V			900	mV
V_{IT-}	Negative-going input threshold voltage, all modes		500			
V_{IT+}	Positive-going input threshold voltage, all modes	See Figure 6, Table 6 and Table 1, S = 0 or V_{CC} or V_{IO}, -30 V ≤ V_{CM} ≤ +30 V			1000	
V_{IT-}	Negative-going input threshold voltage, all modes		400			
V_{HYS}	Hysteresis voltage (V_{IT+} - V_{IT-})	See Figure 6, Table 6 and Table 1, S = 0 or V_{CC} or V_{IO}		120		mV
$I_{lkg(IOFF)}$	Power-off (unpowered) bus input leakage current	CANH = CANL = 5 V, V_{CC} = V_{IO} = 0 V			4.8	µA
C_I	Input capacitance to ground (CANH or CANL)	TXD = V_{CC}, V_{IO} = V_{CC}, V_I = 0.4 * sin (4E6 * π * t) + 2.5 V		24	30	pF
C_{ID}	Differential input capacitance	TXD = V_{CC}, V_{IO} = V_{CC}, V_I = 0.4 * sin (4E6 * π * t)		12	15	pF
R_{ID}	Differential input resistance	TXD = V_{CC} = V_{IO} = 5 V, S = 0 V	30		80	kΩ
R_{IN}	Input resistance (CANH or CANL)		15		40	kΩ
$R_{IN(M)}$	Input resistance matching: [1 – $R_{IN(CANH)}$ / $R_{IN(CANL)}$] × 100%	V_{CANH} = V_{CANL}	–2%		+2%	

7.6 Switching Characteristics

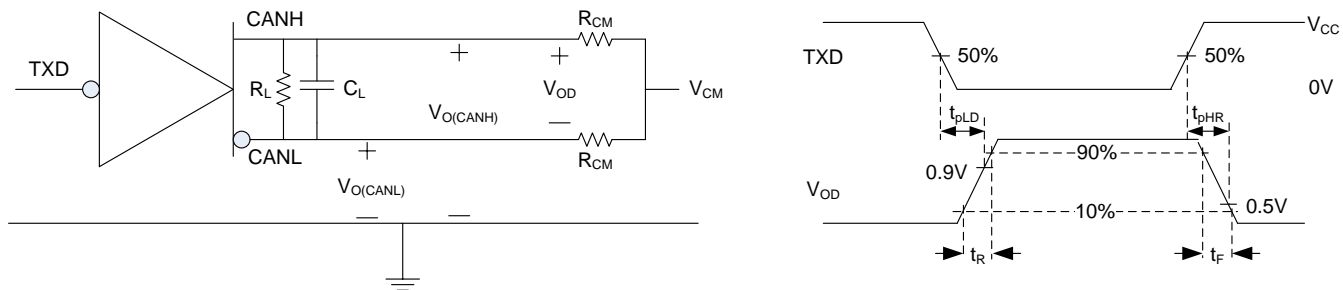Over recommended operating conditions with T_A = -55°C to 125°C (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP[(1)]	MAX	UNIT
DEVICE SWITCHING CHARACTERISTICS						
$t_{PROP(LOOP1)}$	Total loop delay, driver input (TXD) to receiver output (RXD), recessive to dominant	See Figure 8, S = 0 V, R_L = 60 Ω, C_L = 100 pF, $C_{L(RXD)}$ = 15 pF		100	160	ns
$t_{PROP(LOOP2)}$	Total loop delay, driver input (TXD) to receiver output (RXD), dominant to recessive			110	175	
t_{MODE}	Mode change time, from Normal to Silent or from Silent to Normal	See Figure 7		1	10	µs
DRIVER SWITCHING CHARACTERISTICS						
t_{pHR}	Propagation delay time, high TXD to driver recessive (dominant to recessive)	See Figure 5, S= 0 V, R_L = 60 Ω, C_L = 100 pF, R_{CM} = open		75		ns
t_{pLD}	Propagation delay time, low TXD to driver dominant (recessive to dominant)			55		
$t_{sk(p)}$	Pulse skew ($|t_{pHR} - t_{pLD}|$)			20		
t_R	Differential output signal rise time			45		
t_F	Differential output signal fall time			45		
t_{TXD_DTO}	Dominant timeout	See Figure 10, S = 0 V, R_L = 60 Ω, C_L = open	1.2		3.8	ms
RECEIVER SWITCHING CHARACTERISTICS						
t_{pRH}	Propagation delay time, bus recessive input to high output (Dominant to Recessive)	See Figure 6, S = 0 V, $C_{L(RXD)}$ = 15 pF		65		ns
t_{pDL}	Propagation delay time, bus dominant input to low output (Recessive to Dominant)			50		ns
t_R	RXD Output signal rise time			10		ns
t_F	RXD Output signal fall time			10		ns
FD Timing Parameters						
$t_{BIT(BUS)}$	Bit time on CAN bus output pins with $t_{BIT(TXD)}$ = 500 ns, all devices	See Figure 9 , S = 0 V, R_L = 60 Ω, C_L = 100 pF, $C_{L(RXD)}$ = 15 pF, Δt_{REC} = $t_{BIT(RXD)}$ - $t_{BIT(BUS)}$	435		530	ns
	Bit time on CAN bus output pins with $t_{BIT(TXD)}$ = 200 ns, G device variants only		155		210	
$t_{BIT(RXD)}$	Bit time on RXD output pins with $t_{BIT(TXD)}$ = 500 ns, all devices		400		550	
	Bit time on RXD output pins with $t_{BIT(TXD)}$ = 200 ns, G device variants only		120		220	
Δt_{REC}	Receiver timing symmetry with $t_{BIT(TXD)}$ = 500 ns, all devices		-65		40	
	Receiver timing symmetry with $t_{BIT(TXD)}$ = 200 ns, G device variants only		-45		15	

(1) All typical values are at 25°C and supply voltages of V_{CC} = 5 V and V_{IO} = 5 V, R_L = 60 Ω.

7.7 Typical Characteristics

Figure 1. V_{OD(D)} over Temperature

Figure 2. V_{OD(D)} over V_{CC}

Figure 3. I_{CC} Recessive over Temperature

Figure 4. Total Loop Delay over Temperature

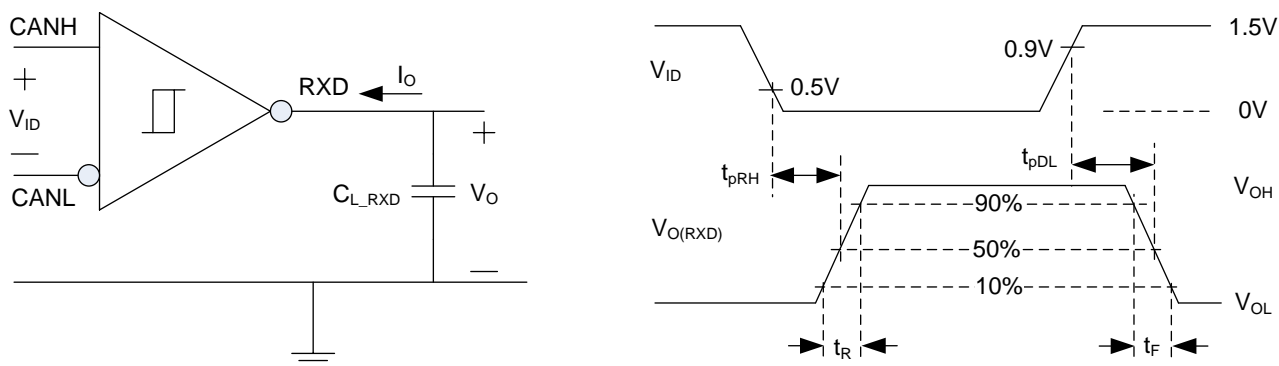Product Folder Links: *TCAN1051H TCAN1051HV TCAN1051HG TCAN1051HGV*

8 Parameter Measurement Information

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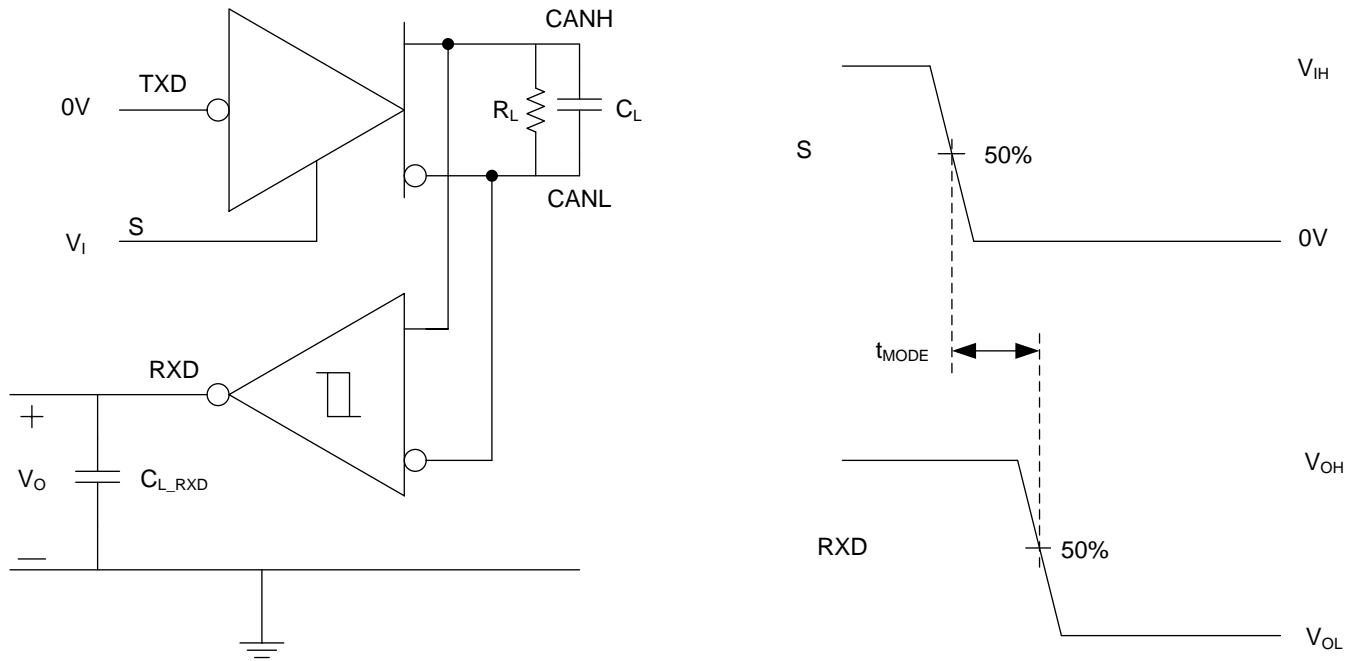
Figure 5. Driver Test Circuit and Measurement

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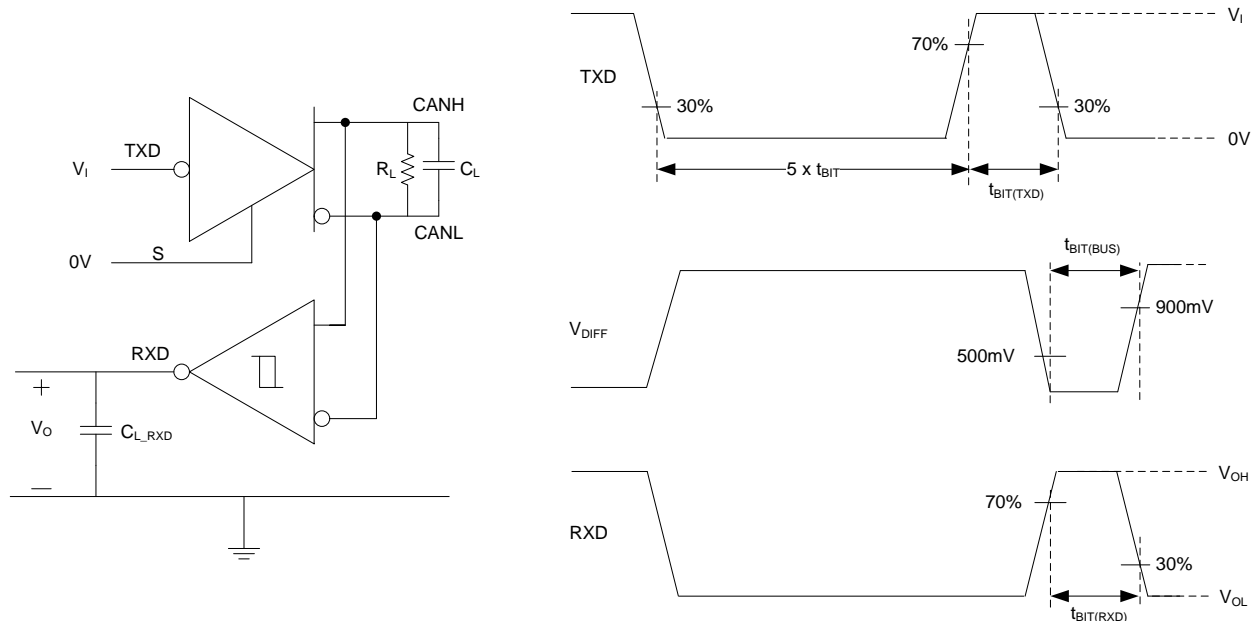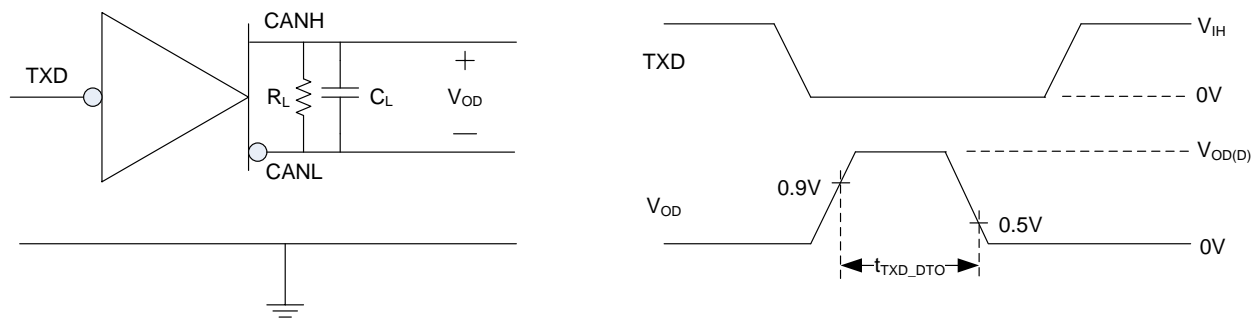
Figure 6. Receiver Test Circuit and Measurement

Table 1. Receiver Differential Input Voltage Threshold Test (See Figure 6)

INPUT			OUTPUT	
V_{CANH}	V_{CANL}	$|V_{ID}|$	RXD	
-29.5 V	-30.5 V	1000 mV	L	
30.5 V	29.5 V	1000 mV	L	
-19.55 V	-20.45 V	900 mV	L	V_{OL}
20.45 V	19.55 V	900 mV	L	
-19.75 V	-20.25 V	500 mV	H	
20.25 V	19.75 V	500 mV	H	
-29.8 V	-30.2 V	400 mV	H	V_{OH}
30.2 V	29.8 V	400 mV	H	
Open	Open	X	H	

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Figure 7. t$_{MODE}$ Test Circuit and Measurement
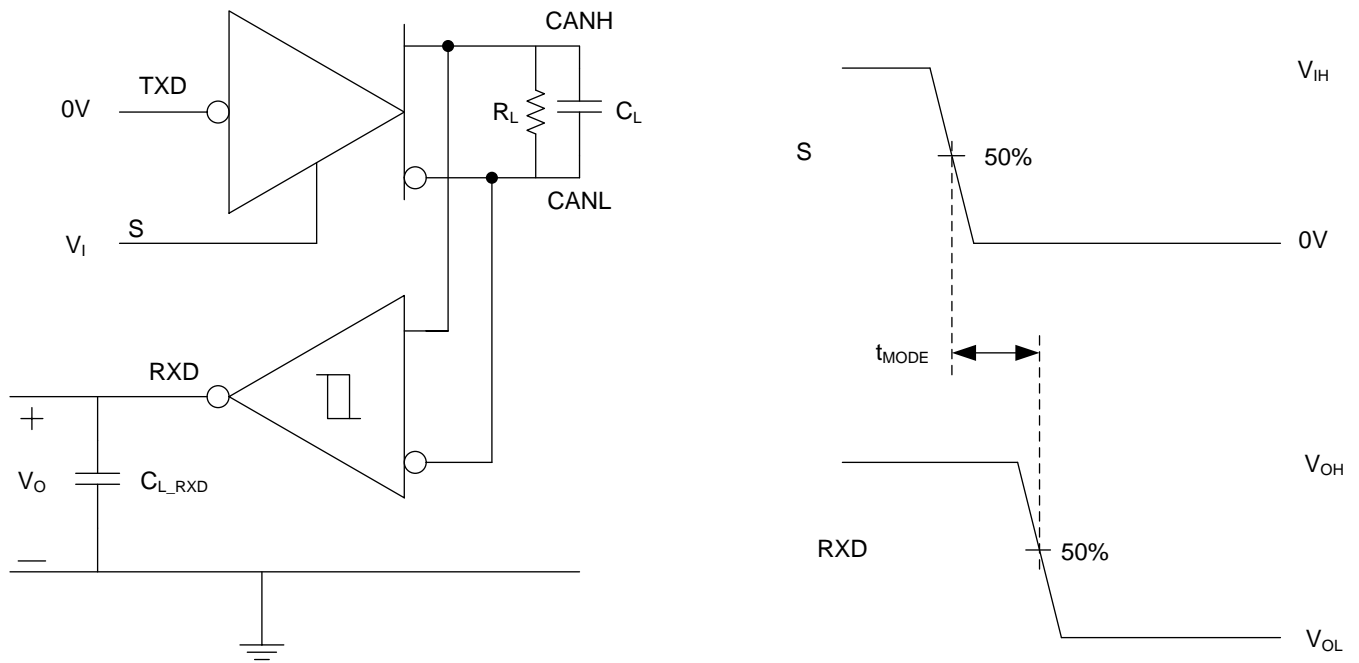
Copyright © 2016, Texas Instruments Incorporated

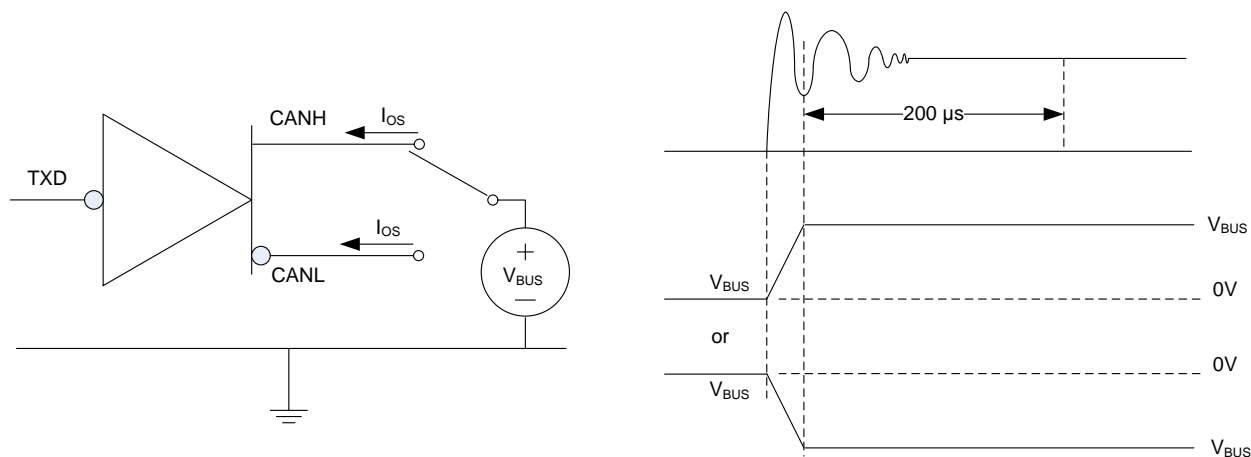**Figure 8. T$_{PROP(LOOP)}$ Test Circuit and Measurement**

Figure 9. CAN FD Timing Parameter Measurement

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Figure 10. TXD Dominant Timeout Test Circuit and Measurement

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Figure 11. Driver Short Circuit Current Test and Measurement

9 Detailed Description

9.1 Overview

These CAN transceivers meet the ISO11898-2 (2016) High Speed CAN (Controller Area Network) physical layer standard. They are designed for data rates in excess of 1 Mbps for CAN FD and enhanced timing margin / higher data rates in long and highly-loaded networks. These devices provide many protection features to enhance device and CAN robustness.

9.2 Functional Block Diagram

Copyright © 2016, Texas Instruments Incorporated
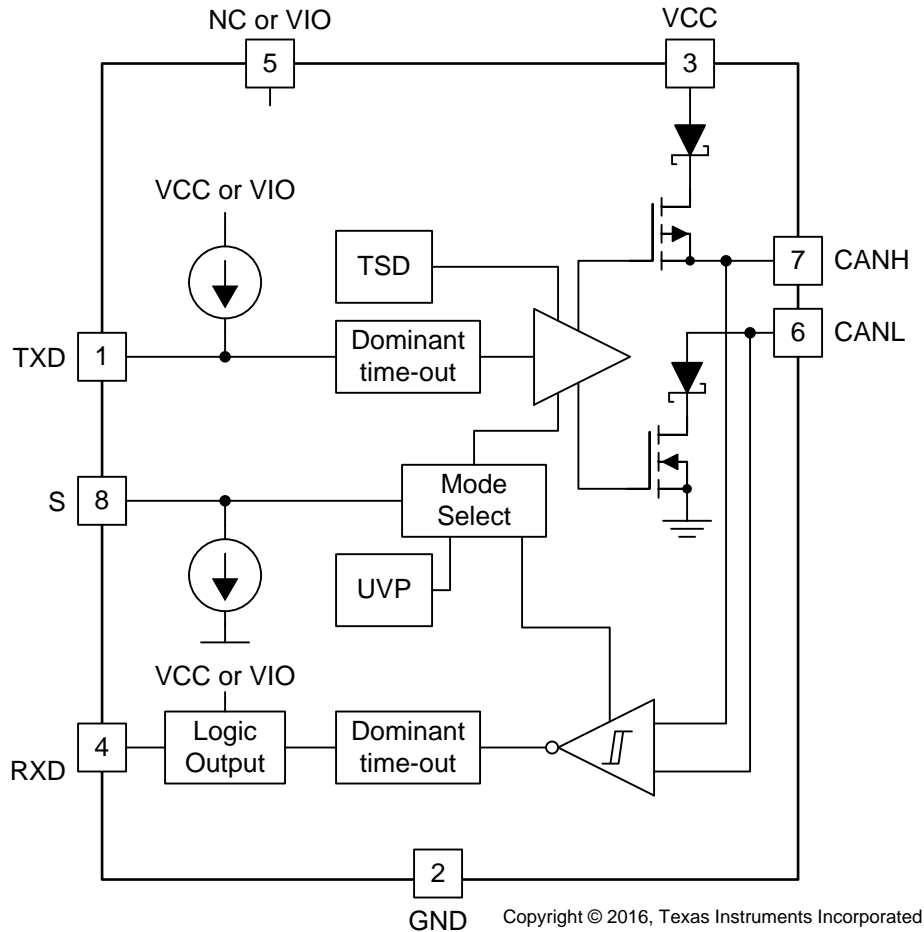
9.3 Feature Description

9.3.1 TXD Dominant Timeout (DTO)

During normal mode (the only mode where the CAN driver is active), the TXD DTO circuit prevents the transceiver from blocking network communication in the event of a hardware or software failure where TXD is held dominant longer than the timeout period t_{TXD_DTO}. The DTO circuit timer starts on a falling edge on TXD. The DTO circuit disables the CAN bus driver if no rising edge is seen before the timeout period expires. This frees the bus for communication between other nodes on the network. The CAN driver is re-activated when a recessive signal is seen on the TXD terminal, thus clearing the TXD DTO condition. The receiver and RXD terminal still reflect activity on the CAN bus, and the bus terminals are biased to the recessive level during a TXD dominant timeout.
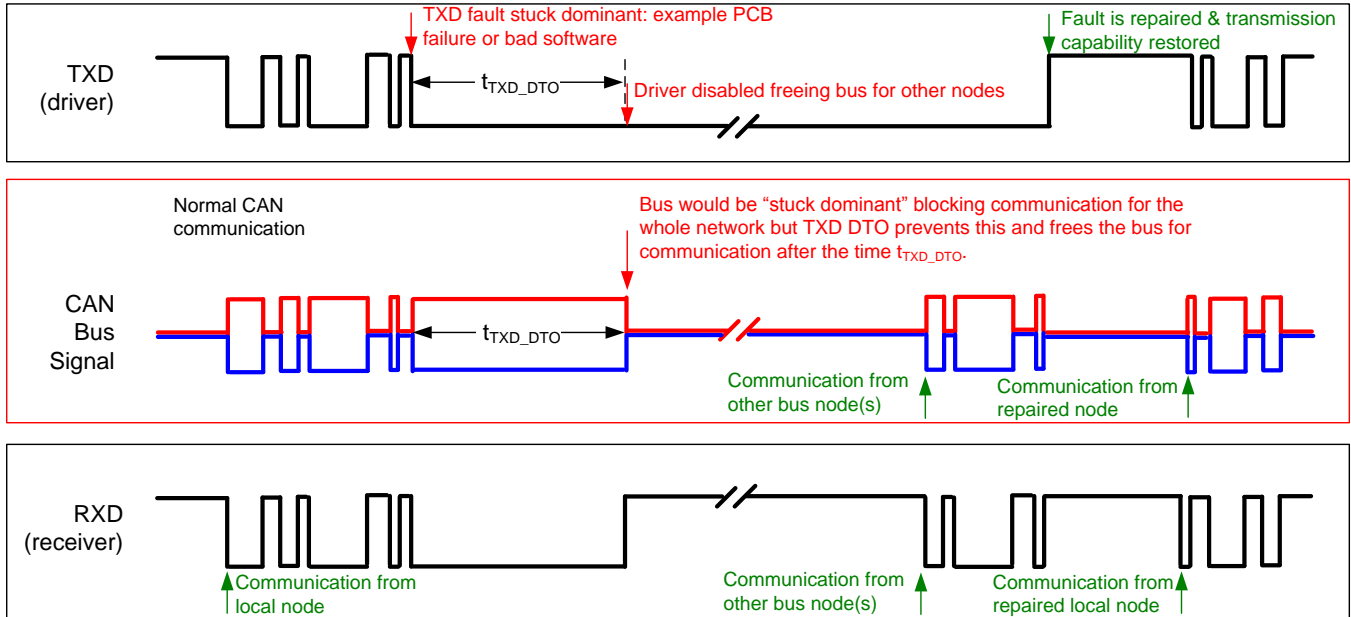

Figure 12. Example Timing Diagram for TXD DTO

NOTE
The minimum dominant TXD time allowed by the TXD DTO circuit limits the minimum possible transmitted data rate of the device. The CAN protocol allows a maximum of eleven successive dominant bits (on TXD) for the worst case, where five successive dominant bits are followed immediately by an error frame. This, along with the t_{TXD_DTO} minimum, limits the minimum data rate. Calculate the minimum transmitted data rate by: Minimum Data Rate = $11 / t_{TXD\_DTO}$.

9.3.2 Thermal Shutdown (TSD)

If the junction temperature of the device exceeds the thermal shutdown threshold (T_{TSD}), the device turns off the CAN driver circuits thus blocking the TXD-to-bus transmission path. The CAN bus terminals are biased to the recessive level during a thermal shutdown, and the receiver-to-RXD path remains operational. The shutdown condition is cleared when the junction temperature drops at least the thermal shutdown hysteresis temperature (T_{TSD_HYS}) below the thermal shutdown temperature (T_{TSD}) of the device.

Feature Description (continued)

9.3.3 Undervoltage Lockout

The supply terminals have undervoltage detection that places the device in protected mode. This protects the bus during an undervoltage event on either the V_{CC} or V_{IO} supply terminals.

Table 2. Undervoltage Lockout 5 V Only Devices (Devices without the "V" Suffix)[1]

V_{CC}	DEVICE STATE	BUS OUTPUT	RXD
> UV$_{VCC}$	Normal	Per TXD	Mirrors Bus[2]
< UV$_{VCC}$	Protected	High Impedance	High Impedance

(1) See the V_{IT} section of the *Electrical Characteristics*.
(2) Mirrors bus state: low if CAN bus is dominant, high if CAN bus is recessive.

Table 3. Undervoltage Lockout I/O Level Shifting Devices (Devices with the "V" Suffix)

V_{CC}	V_{IO}	DEVICE STATE	BUS OUTPUT	RXD
> UV$_{VCC}$	> UV$_{VIO}$	Normal	Per TXD	Mirrors Bus[1]
< UV$_{VCC}$	> UV$_{VIO}$	Protected	High Impedance	High (Recessive)
> UV$_{VCC}$	< UV$_{VIO}$	Protected	Recessive	High Impedance
< UV$_{VCC}$	< UV$_{VIO}$	Protected	High Impedance	High Impedance

(1) Mirrors bus state: low if CAN bus is dominant, high if CAN bus is recessive.

> **NOTE**
>
> After an undervoltage condition is cleared and the supplies have returned to valid levels, the device typically resumes normal operation within 50 μs.

9.3.4 Unpowered Device

The device is designed to be 'ideal passive' or 'no load' to the CAN bus if it is unpowered. The bus terminals (CANH, CANL) have extremely low leakage currents when the device is unpowered to avoid loading down the bus. This is critical if some nodes of the network are unpowered while the rest of the of network remains in operation. The logic terminals also have extremely low leakage currents when the device is unpowered to avoid loading down other circuits that may remain powered.

9.3.5 Floating Terminals

These devices have internal pull ups on critical terminals to place the device into known states if the terminals float. The TXD terminal is pulled up to V_{CC} or V_{IO} to force a recessive input level if the terminal floats. The S terminal is also pulled down to force the device into Normal mode if the terminal floats.

9.3.6 CAN Bus Short Circuit Current Limiting

The device has two protection features that limit the short circuit current when a CAN bus line is short-circuit fault condition: driver current limiting (both dominant and recessive states) and TXD dominant state time out to prevent permanent higher short circuit current of the dominant state during a system fault. During CAN communication the bus switches between dominant and recessive states, thus the short circuit current may be viewed either as the instantaneous current during each bus state or as an average current of the two states. For system current (power supply) and power considerations in the termination resistors and common-mode choke ratings, use the average short circuit current. Determine the ratio of dominant and recessive bits by the data in the CAN frame plus the following factors of the protocol and PHY that force either recessive or dominant at certain times:

- Control fields with set bits
- Bit stuffing
- Interframe space
- TXD dominant time out (fault case limiting)

Product Folder Links: *TCAN1051H TCAN1051HV TCAN1051HG TCAN1051HGV*

These ensure a minimum recessive amount of time on the bus even if the data field contains a high percentage of dominant bits. The short circuit current of the bus depends on the ratio of recessive to dominant bits and their respective short circuit currents. The average short circuit current may be calculated with the following formula:

$$I_{OS(AVG)} = \%Transmit \times [(\%REC\_Bits \times I_{OS(SS)\_REC}) + (\%DOM\_Bits \times I_{OS(SS)\_DOM})] + [\%Receive \times I_{OS(SS)\_REC}] \qquad (1)$$

Where:

- $I_{OS(AVG)}$ is the average short circuit current
- %Transmit is the percentage the node is transmitting CAN messages
- %Receive is the percentage the node is receiving CAN messages
- %REC_Bits is the percentage of recessive bits in the transmitted CAN messages
- %DOM_Bits is the percentage of dominant bits in the transmitted CAN messages
- $I_{OS(SS)\_REC}$ is the recessive steady state short circuit current
- $I_{OS(SS)\_DOM}$ is the dominant steady state short circuit current

NOTE
Consider the short circuit current and possible fault cases of the network when sizing the power ratings of the termination resistance and other network components.

9.3.7 Digital Inputs and Outputs

9.3.7.1 5-V V_{CC} Only Devices (Devices without the "V" Suffix):

The 5-V V_{CC} only devices are supplied by a single 5-V rail. The digital inputs have TTL input thresholds and are therefore 5 V and 3.3 V compatible. The RXD outputs on these devices are driven to the V_{CC} rail for logic high output. Additionally, the TXD pin is internally pulled up to V_{CC}, and the S pin is pulled low to GND. The internal bias of the mode pins may only place the device into a known state if the terminals float, they may not be adequate for system-level biasing during transients or noisy enviroments.

NOTE
TXD pull up strength and CAN bit timing require special consideration when these devices are used with CAN controllers with an open-drain TXD output. An adequate external pull up resistor must be used to ensure that the CAN controller output of the micrcontroller maintains adequate bit timing to the TXD input.

9.3.7.2 5 V V_{CC} with V_{IO} I/O Level Shifting (Devices with the "V" Suffix):

These devices use a 5 V V_{CC} power supply for the CAN driver and high speed receiver blocks. These transceivers have a second power supply for I/O level-shifting (V_{IO}). This supply is used to set the CMOS input thresholds of the TXD and S pins and the RXD high level output voltage. Additionally, the TXD pin is internally pulled up to V_{IO}, and the S pin is pulled low to GND.

9.4 Device Functional Modes

The device has two main operating modes: Normal mode and Silent mode. Operating mode selection is made via the S input terminal.

Table 4. Operating Modes

S Terminal	MODE	DRIVER	RECEIVER	RXD Terminal
LOW	Normal Mode	Enabled (ON)	Enabled (ON)	Mirrors Bus State[1]
HIGH	Silent Mode	Disabled (OFF)	Enabled (ON)	Mirrors Bus State[1]

(1) Mirrors bus state: low if CAN bus is dominant, high if CAN bus is recessive.

9.4.1 CAN Bus States

The CAN bus has two states during powered operation of the device: *dominant* and *recessive*. A dominant bus state is when the bus is driven differentially, corresponding to a logic low on the TXD and RXD terminal. A recessive bus state is when the bus is biased to V_{CC} / 2 via the high-resistance internal input resistors R_{IN} of the receiver, corresponding to a logic high on the TXD and RXD terminals.
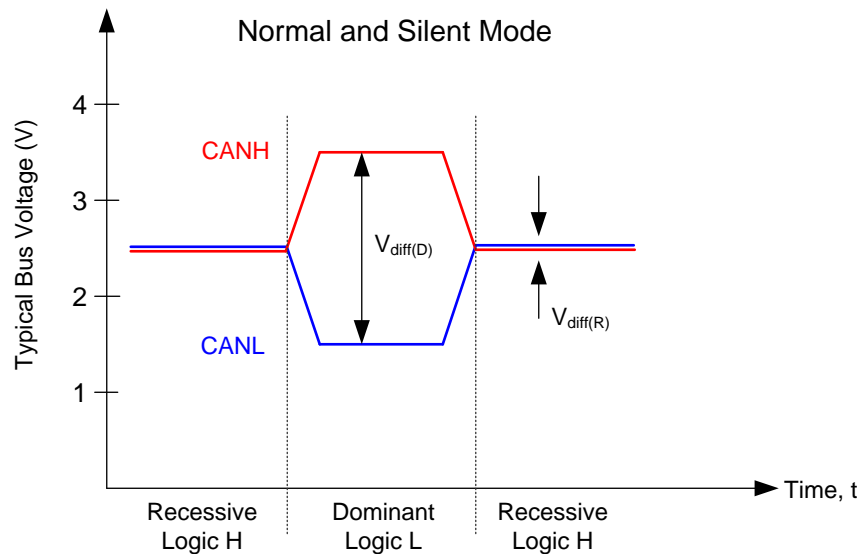
Figure 13. Bus States (Physical Bit Representation)

9.4.2 Normal Mode

Select the *Normal mode* of device operation by setting S terminal low. The CAN driver and receiver are fully operational and CAN communication is bi-directional. The driver translates a digital input on TXD to a differential output on CANH and CANL. The receiver translates the differential signal from CANH and CANL to a digital output on RXD.

9.4.3 Silent Mode

Activate *Silent mode* by setting S terminal high. The CAN driver is disabled, preventing communication from the TXD pin to the CAN bus. The high speed receiver remains active so that CAN bus communication continues to be relayed to the RXD output pin.

Product Folder Links: *TCAN1051H TCAN1051HV TCAN1051HG TCAN1051HGV*

9.4.4 Driver and Receiver Function Tables

Table 5. Driver Function Table

DEVICE	INPUTS		OUTPUTS		DRIVEN BUS STATE
	S [1]	TXD[1] [2]	CANH[1]	CANL[1]	
All Devices	L or open	L	H	L	Dominant
		H or Open	Z	Z	Recessive
	H	X	Z	Z	Recessive

(1) H = high level, L = low level, X = irrelevant, Z = common mode (recessive) bias to V_{CC} / 2. See Figure 13 and for bus state and common mode bias information.
(2) Devices have an internal pull up to V_{CC} or V_{IO} on TXD terminal. If the TXD terminal is open the terminal will be pulled high and the transmitter will remain in recessive (non-driven) state.

Table 6. Receiver Function Table

DEVICE MODE	CAN DIFFERENTIAL INPUTS $V_{ID} = V_{CANH} - V_{CANL}$	BUS STATE	RXD TERMINAL[1]
Normal or Silent	$V_{ID} \geq V_{IT+(MAX)}$	Dominant	L [2]
	$V_{IT-(MIN)} < V_{ID} < V_{IT+(MAX)}$	?	? [2]
	$V_{ID} \leq V_{IT-(MIN)}$	Recessive	H [2]
	Open ($V_{ID} \approx 0$ V)	Open	H

(1) H = high level, L = low level, ? = indeterminate.
(2) See Receiver Electrical Characteristics section for input thresholds.

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Product Folder Links: *TCAN1051H TCAN1051HV TCAN1051HG TCAN1051HGV*

10 Application and Implementation

> **NOTE**
>
> Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

10.1 Application Information

These CAN transceivers are typically used in applications with a host microprocessor or FPGA that includes the data link layer portion of the CAN protocol. Below are typical application configurations for both 5 V and 3.3 V microprocessor applications. The bus termination is shown for illustrative purposes.

10.2 Typical Applications
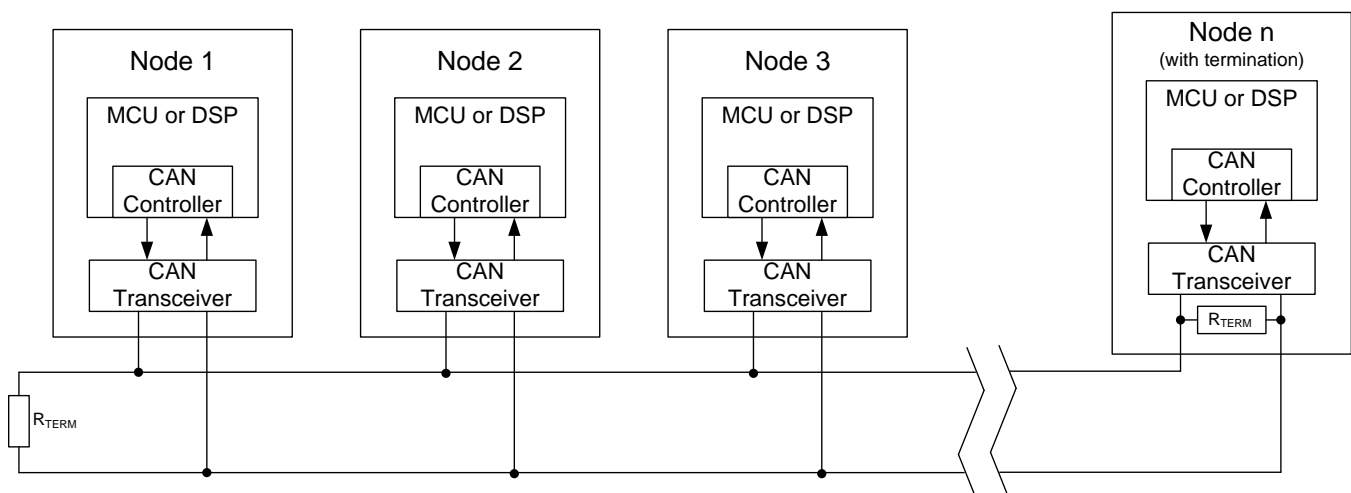
Figure 14. Typical CAN Bus Application

10.2.1 Design Requirements

10.2.1.1 Bus Loading, Length and Number of Nodes

The ISO 11898-2 Standard specifies a maximum bus length of 40 m and maximum stub length of 0.3 m. However, with careful design, users can have longer cables, longer stub lengths, and many more nodes to a bus. A large number of nodes requires transceivers with high input impedance such as the TCAN1051 family of transceivers.

Many CAN organizations and standards have scaled the use of CAN for applications outside the original ISO 11898-2. They have made system-level trade-offs for data rate, cable length, and parasitic loading of the bus. Examples of some of these specifications are ARINC825, CANopen, DeviceNet and NMEA2000.

The TCAN1051 family is specified to meet the 1.5 V requirement with a 50Ω load, incorporating the worst case including parallel transceivers. The differential input resistance of the TCAN1051 family is a minimum of 30 kΩ. If 100 TCAN1051 family transceivers are in parallel on a bus, this is equivalent to a 300Ω differential load worst case. That transceiver load of 300 Ω in parallel with the 60Ω gives an equivalent loading of 50 Ω. Therefore, the TCAN1051 family theoretically supports up to 100 transceivers on a single bus segment. However, for CAN network design margin must be given for signal loss across the system and cabling, parasitic loadings, network imbalances, ground offsets and signal integrity thus a practical maximum number of nodes is typically much lower. Bus length may also be extended beyond the original ISO 11898 standard of 40 m by careful system design and datarate tradeoffs. For example CANopen network design guidelines allow the network to be up to 1 km with changes in the termination resistance, cabling, less than 64 nodes and significantly lowered data rate.

Typical Applications (continued)

This flexibility in CAN network design is one of the key strengths of the various extensions and additional standards that have been built on the original ISO 11898-2 CAN standard. In using this flexibility comes the responsibility of good network design and balancing these tradeoffs.

10.2.2 Detailed Design Procedures

10.2.2.1 CAN Termination

The ISO 11898 standard specifies the interconnect to be a twisted pair cable (shielded or unshielded) with 120-Ω characteristic impedance (Z_O). Resistors equal to the characteristic impedance of the line should be used to terminate both ends of the cable to prevent signal reflections. Unterminated drop lines (stubs) connecting nodes to the bus should be kept as short as possible to minimize signal reflections. The termination may be on the cable or in a node, but if nodes may be removed from the bus, the termination must be carefully placed so that two terminations always exist on the network.

Termination may be a single 120-Ω resistor at the end of the bus, either on the cable or in a terminating node. If filtering and stabilization of the common mode voltage of the bus is desired, then split termination may be used. (See Figure 15). Split termination improves the electromagnetic emissions behavior of the network by eliminating fluctuations in the bus common-mode voltages at the start and end of message transmissions.
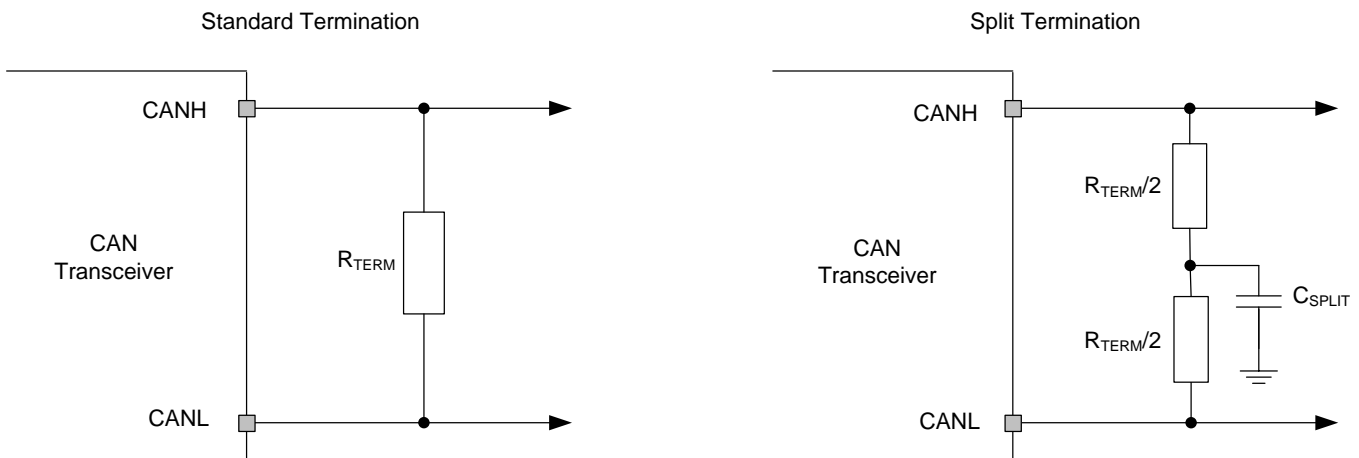
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Figure 15. CAN Bus Termination Concepts

The TCAN1051 family of transceivers have variants for both 5-V only applications and applications where level shifting is needed for a 3.3-V micrcontroller.

Typical Applications (continued)
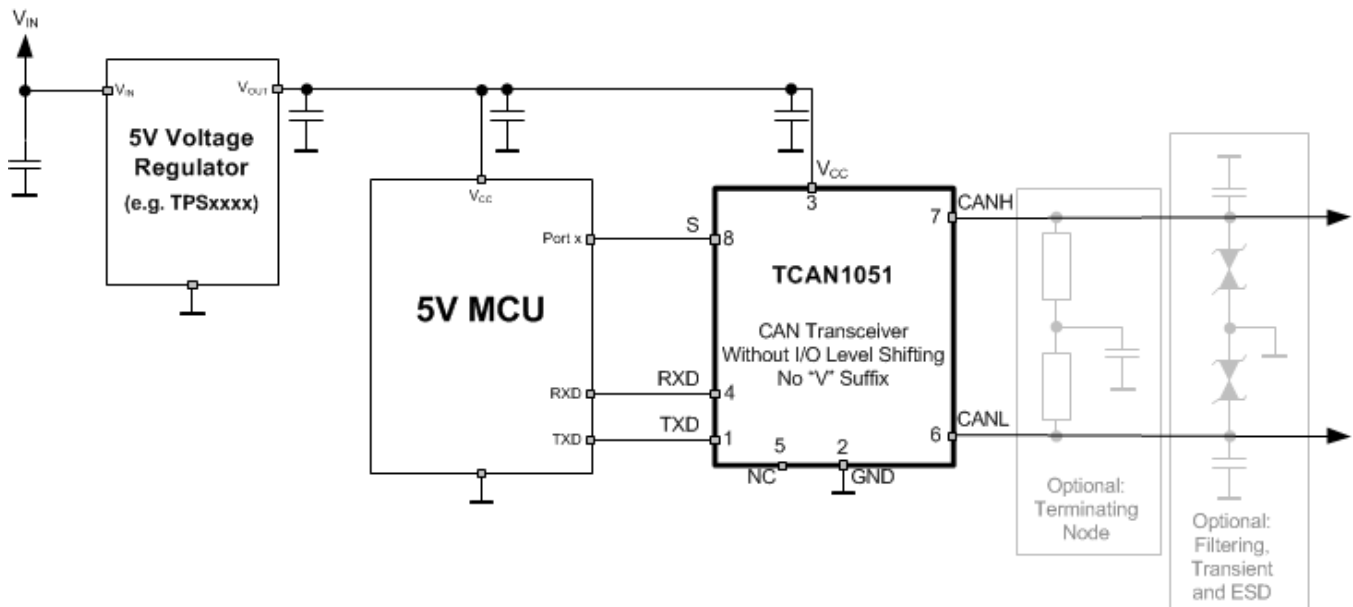
Figure 16. Typical CAN Bus Application Using 5 V CAN Controller
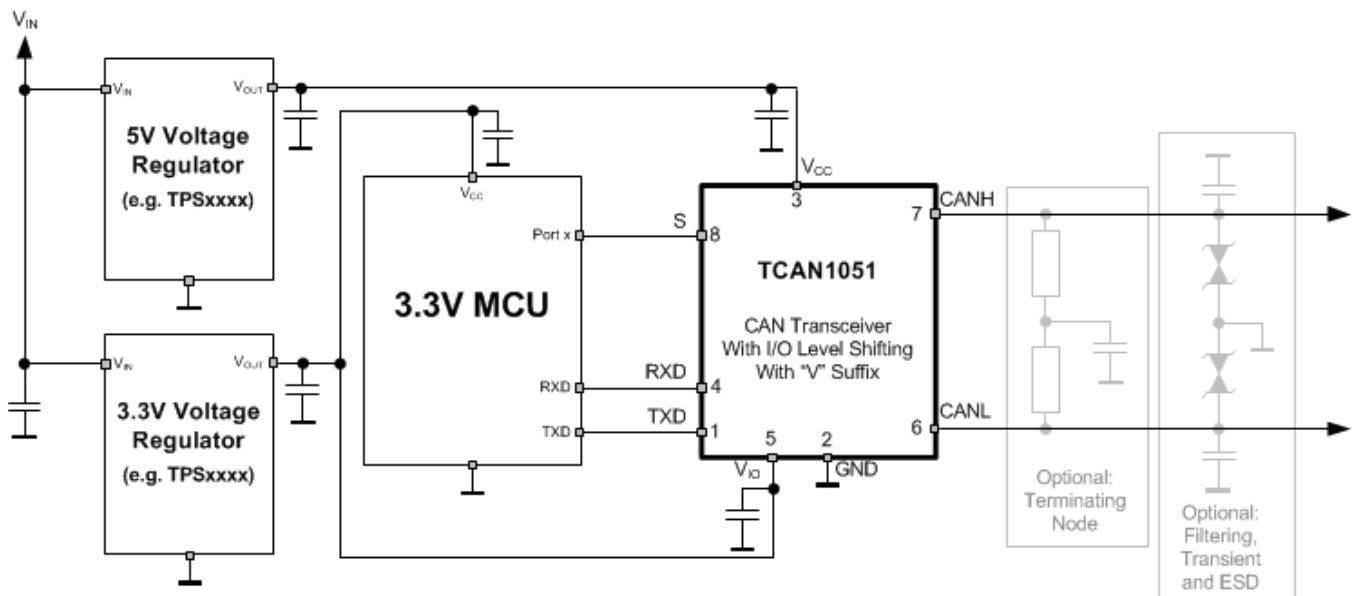
Figure 17. Typical CAN Bus Application Using 3.3 V CAN Controller

Typical Applications (continued)

10.2.3 Application Curves
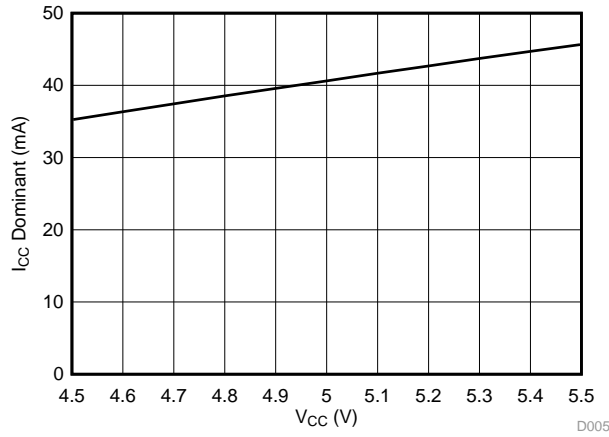
V_{CC} = 4.5 V to 5.5 V	V_{IO} = 3.3 V	R_L = 60 Ω
C_L = Open	Temp = 25°C	S = 0 V

Figure 18. I_{CC} Dominant Current over V_{CC} Supply Voltage

Product Folder Links: *TCAN1051H TCAN1051HV TCAN1051HG TCAN1051HGV*

11 Power Supply Requirements

These devices are designed to operate from a V_{CC} input supply voltage range between 4.5 V and 5.5 V. Some devices have an output level shifting supply input, V_{IO}, designed for a range between 3.0 V and 5.5 V. Both supply inputs must be well regulated. A bulk capacitance, typically 4.7 µF, should be placed near the CAN transceiver's main V_{CC} supply output, and in addition a bypass capacitor, typically 0.1 µF, should be placed as close to the device's V_{CC} and V_{IO} supply terminals. This helps to reduce supply voltaeg ripple present on the outputs of the switched-mode power supplies and also helps to compensate for the resistance and inductance of the PCB power planes and traces.

12 Layout

Robust and reliable bus node design often requires the use of external transient protection device in order to protect against EFT and surge transients that may occur in industrial enviroments. Because ESD and transients have a wide frequency bandwidth from approximately 3 MHz to 3 GHz, high-frequency layout techniques must be applied during PCB design. The TCAN1051 family comes with high on-chip IEC ESD protection, but if higher levels of system level immunity are desired external TVS diodes can be used. TVS diodes and bus filtering capacitors should be placed as close to the on-board connectors as possible to prevent noisy transient events from propagating further into the PCB and system.

Product Folder Links: *TCAN1051H TCAN1051HV TCAN1051HG TCAN1051HGV*

12.1 Layout Guidelines

- Place the protection and filtering circuitry as close to the bus connector, J1, to prevent transients, ESD and noise from propagating onto the board. In this layout example a transient voltage suppression (TVS) device, D1, has been used for added protection. The production solution can be either bi-directional TVS diode or varistor with ratings matching the application requirements. This example also shows optional bus filter capacitors C4 and C5. Additionally (not shown) a series common mode choke (CMC) can be placed on the CANH and CANL lines between the transceiver U1 and connector J1.

- Design the bus protection components in the direction of the signal path. Do not force the transient current to divert from the signal path to reach the protection device.

- Use supply (V_{CC}) and ground planes to provide low inductance.

NOTE

High-frequency currents follows the path of least impedance and not the path of least resistance.

- Use at least two vias for supply (V_{CC}) and ground connections of bypass capacitors and protection devices to minimize trace and via inductance.

- Bypass and bulk capacitors should be placed as close as possible to the supply terminals of transceiver, examples are C1, C2 on the V_{CC} supply and C6 and C7 on the V_{IO} supply.

- Bus termination: this layout example shows split termination. This is where the termination is split into two resistors, R6 and R7, with the center or split tap of the termination connected to ground via capacitor C3. Split termination provides common mode filtering for the bus. When bus termination is placed on the board instead of directly on the bus, additional care must be taken to ensure the terminating node is not removed from the bus thus also removing the termination. See the application section for information on power ratings needed for the termination resistor(s).

- To limit current of digital lines, serial resistors may be used. Examples are R2, R3, and R4. These are not required.

- Terminal 1: R1 is shown optionally for the TXD input of the device. If an open drain host processor is used, this is mandatory to ensure the bit timing into the device is met.

- Terminal 5: For "V" variants of the TCAN1051 family, bypass capacitors should be placed as close to the pin as possible (example C6 and C7). For device options without V_{IO} I/O level shifting, this pin is not internally connected and can be left floating or tied to any existing net, for example a split pin connection.

- Terminal 8: is shown assuming the mode terminal, S, will be used. If the device will only be used in normal mode, R4 is not needed and R5 could be used for the pull down resistor to GND.

12.2 Layout Example
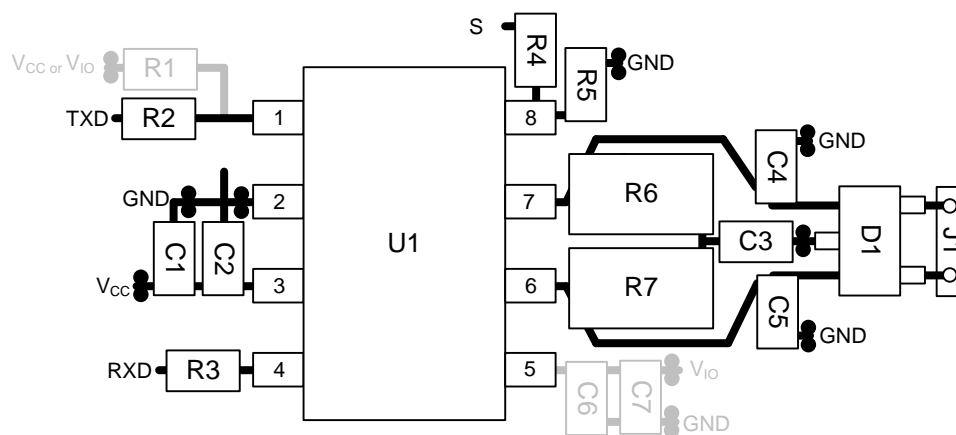
13 Device and Documentation Support

13.1 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

Table 7. Related Links

PARTS	PRODUCT FOLDER	SAMPLE & BUY	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY
TCAN1051H	Click here	Click here	Click here	Click here	Click here
TCAN1051HV	Click here	Click here	Click here	Click here	Click here
TCAN1051HG	Click here	Click here	Click here	Click here	Click here
TCAN1051HGV	Click here	Click here	Click here	Click here	Click here

13.2 Trademarks

All trademarks are the property of their respective owners.

13.3 Electrostatic Discharge Caution

These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

13.4 Glossary

SLYZ022 — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

14 Mechanical, Packaging, and Orderable Information

The following pages include mechanical packaging and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGE OUTLINE

D0008B

SOIC - 1.75 mm max height

SOIC

4221445/B   04/2014
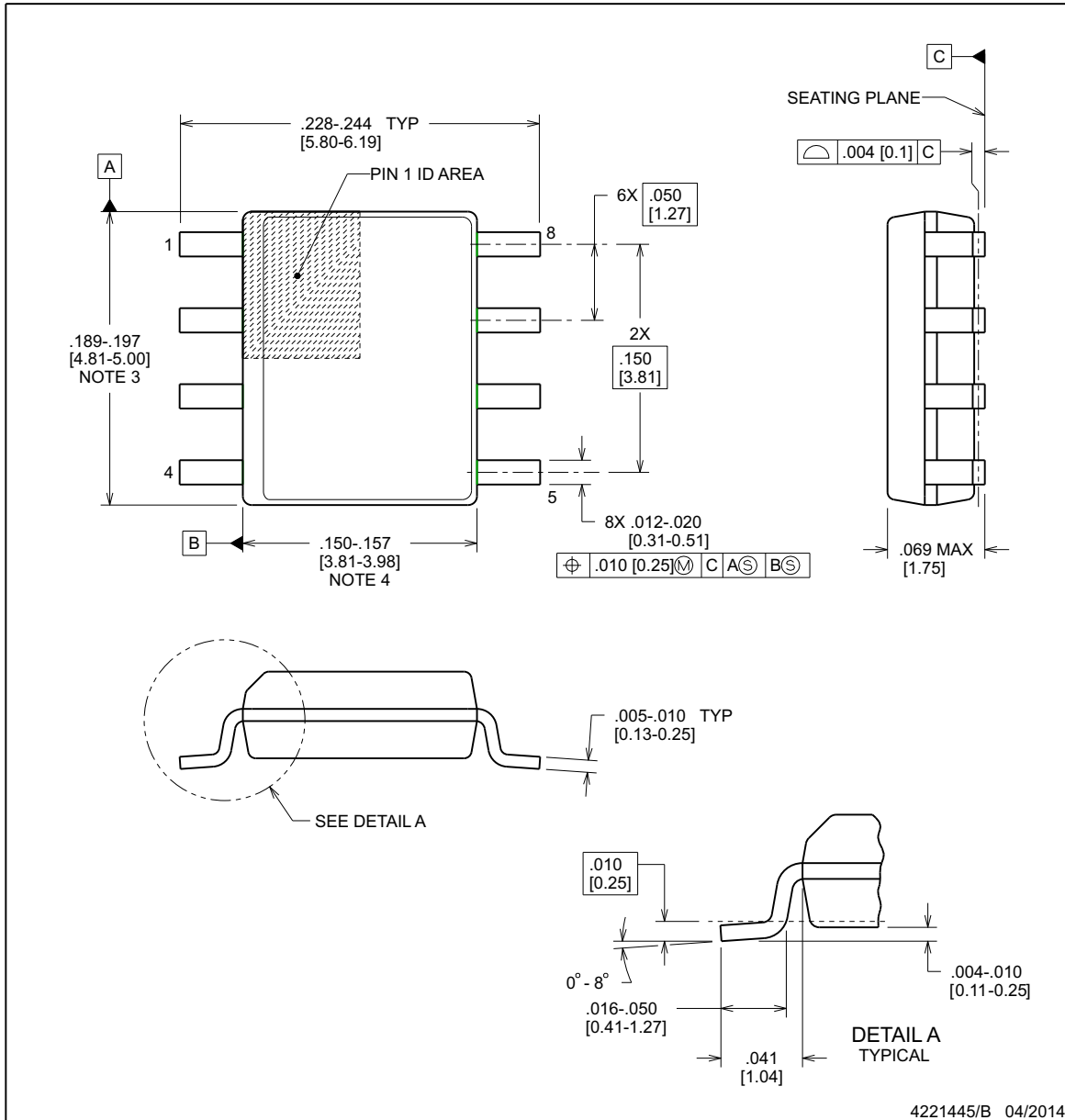
NOTES:

1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches.
   Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
   exceed .006 [0.15], per side.
4. This dimension does not include interlead flash.
5. Reference JEDEC registration MS-012, variation AA.

Product Folder Links: *TCAN1051H TCAN1051HV TCAN1051HG TCAN1051HGV*

EXAMPLE BOARD LAYOUT

D0008B

SOIC - 1.75 mm max height

SOIC

8X (.061)
[1.55]

1

SYMM

SEE DETAILS

8

8X (.024)
[0.6]

SYMM

6X (.050)
[1.27]

4

5

(.213)
[5.4]

IPC-7351 NOMINAL
.150 [3.85] CLEARANCE / CREEPAGE

8X (.055)
[1.4]

1

SYMM

SEE DETAILS

8

8X (.024)
[0.6]

SYMM

6X (.050)
[1.27]

4

5

(.217)
[5.5]

HV / ISOLATION OPTION
.162 [4.1] CLEARANCE / CREEPAGE

LAND PATTERN EXAMPLE
SCALE:6X

METAL

SOLDER MASK OPENING

.0028 MAX
[0.07]
ALL AROUND

NON SOLDER MASK DEFINED

SOLDER MASK OPENING

METAL

.0028 MIN
[0.07]
ALL AROUND

SOLDER MASK DEFINED

SOLDER MASK DETAILS

4221445/B   04/2014

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

Product Folder Links: *TCAN1051H TCAN1051HV TCAN1051HG TCAN1051HGV*

EXAMPLE STENCIL DESIGN

D0008B

SOIC - 1.75 mm max height

SOIC

SOLDER PASTE EXAMPLE
BASED ON .005 INCH [0.127 MM] THICK STENCIL
SCALE:6X

4221445/B 04/2014
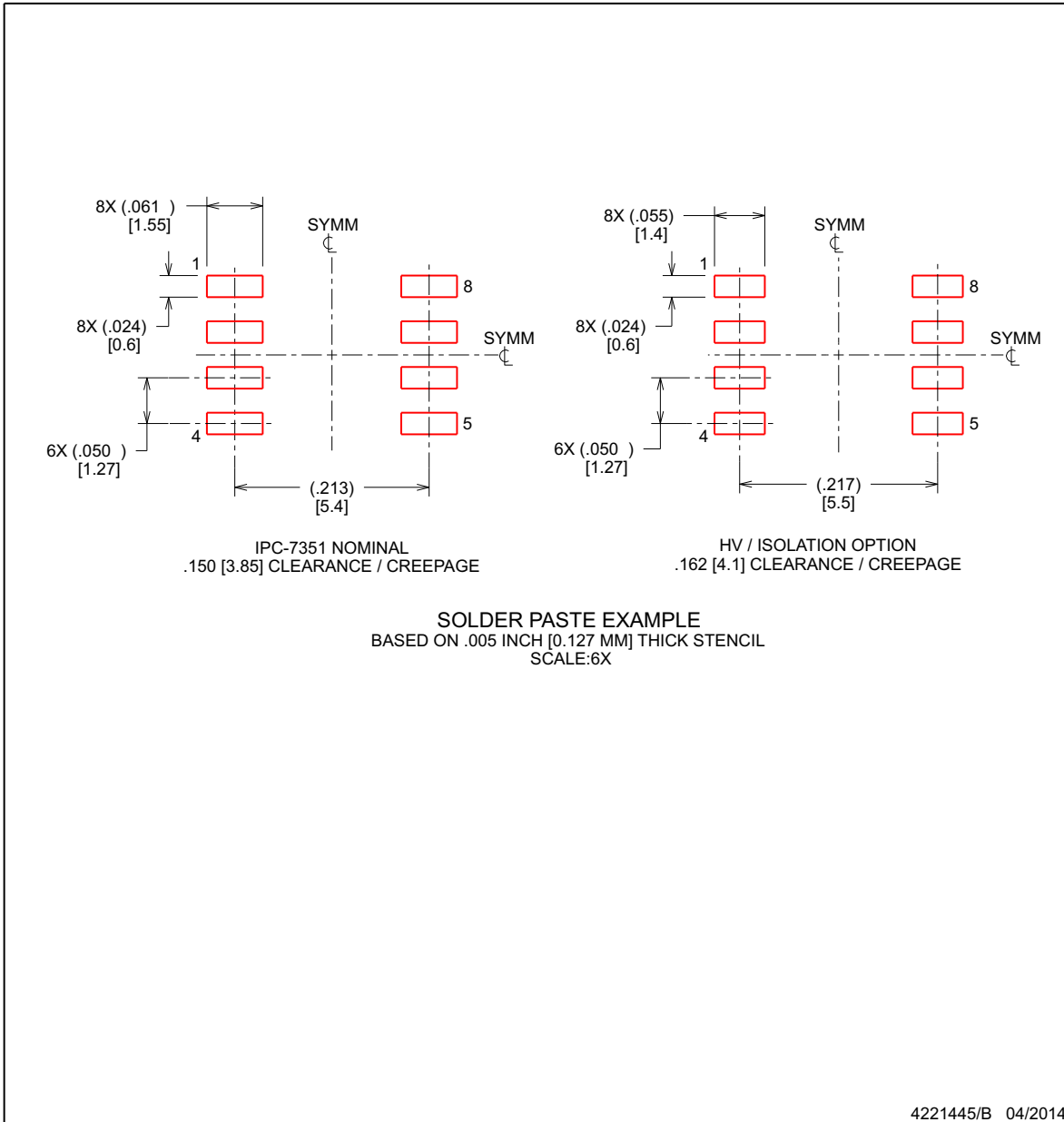
NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

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Product Folder Links: *TCAN1051H TCAN1051HV TCAN1051HG TCAN1051HGV*

PACKAGE OUTLINE

DRB0008F

VSON - 1 mm max height

PLASTIC SMALL OUTLINE - NO LEAD

SECTION A-A
TYPICAL

SEATING PLANE

EXPOSED
THERMAL PAD

PIN 1 ID
(OPTIONAL)

4222121/A 11/2015

NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

Product Folder Links: *TCAN1051H TCAN1051HV TCAN1051HG TCAN1051HGV*

EXAMPLE BOARD LAYOUT

DRB0008F

VSON - 1 mm max height

PLASTIC SMALL OUTLINE - NO LEAD

LAND PATTERN EXAMPLE
SCALE:20X

SOLDER MASK DETAILS

NON SOLDER MASK DEFINED (PREFERRED)

SOLDER MASK DEFINED

4222121/A   11/2015
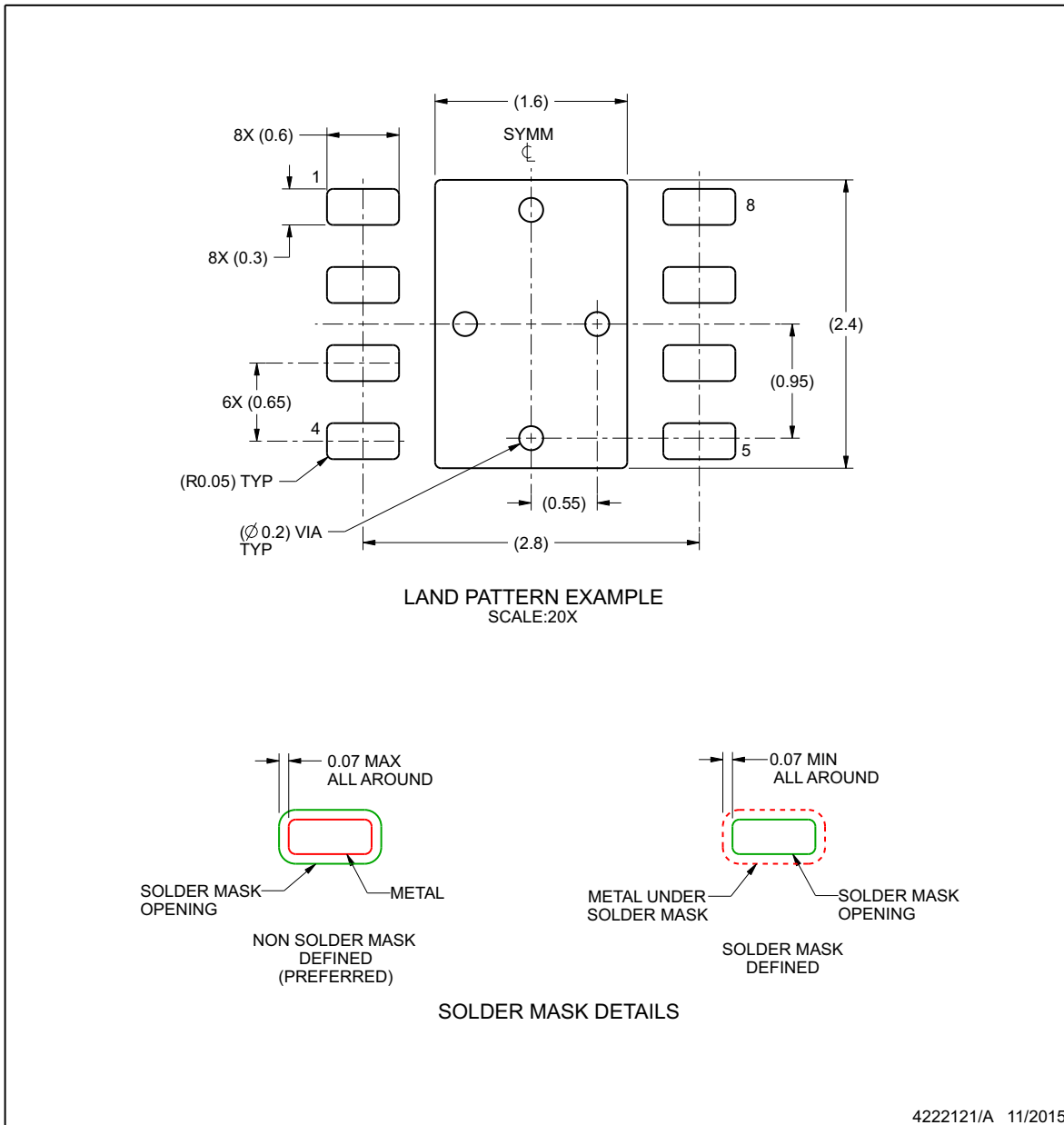
NOTES: (continued)

4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
5. Vias are optional depending on application, refer to device data sheet. If some or all are implemented, recommended via locations are shown.

Product Folder Links: *TCAN1051H TCAN1051HV TCAN1051HG TCAN1051HGV*

TCAN1051H, TCAN1051HV
TCAN1051HG, TCAN1051HGV
SLLSES8B – MARCH 2016 – REVISED MAY 2016

TEXAS
INSTRUMENTS

www.ti.com

EXAMPLE STENCIL DESIGN

DRB0008F

VSON - 1 mm max height

PLASTIC SMALL OUTLINE - NO LEAD

8X (0.6)

1

8X (0.3)

SYMM

6X (0.65)

4

(R0.05) TYP

SYMM

METAL
TYP

8

(0.635)

(1.07)

5

(1.47)

(2.8)

SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL

EXPOSED PAD
82% PRINTED SOLDER COVERAGE BY AREA
SCALE:25X

4222121/A 11/2015

NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate
design recommendations.

Submit Documentation Feedback

Product Folder Links: *TCAN1051H TCAN1051HV TCAN1051HG TCAN1051HGV*

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
TCAN1051HD	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	1051	Samples
TCAN1051HDR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	1051	Samples
TCAN1051HGD	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	1051	Samples
TCAN1051HGDR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	1051	Samples
TCAN1051HGVD	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	1051V	Samples
TCAN1051HGVDR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	1051V	Samples
TCAN1051HVD	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	1051V	Samples
TCAN1051HVDR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	1051V	Samples

(1) The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.
TBD: The Pb-Free/Green conversion plan has not been defined.
Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.
Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.
Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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OTHER QUALIFIED VERSIONS OF TCAN1051H, TCAN1051HG, TCAN1051HGV, TCAN1051HV :

● Automotive: TCAN1051H-Q1, TCAN1051HG-Q1, TCAN1051HGV-Q1, TCAN1051HV-Q1

NOTE: Qualified Version Definitions:

● Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

IMPORTANT NOTICE

Products		**Applications**	
Audio	www.ti.com/audio	Automotive and Transportation	www.ti.com/automotive
Amplifiers	amplifier.ti.com	Communications and Telecom	www.ti.com/communications
Data Converters	dataconverter.ti.com	Computers and Peripherals	www.ti.com/computers
DLP® Products	www.dlp.com	Consumer Electronics	www.ti.com/consumer-apps
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